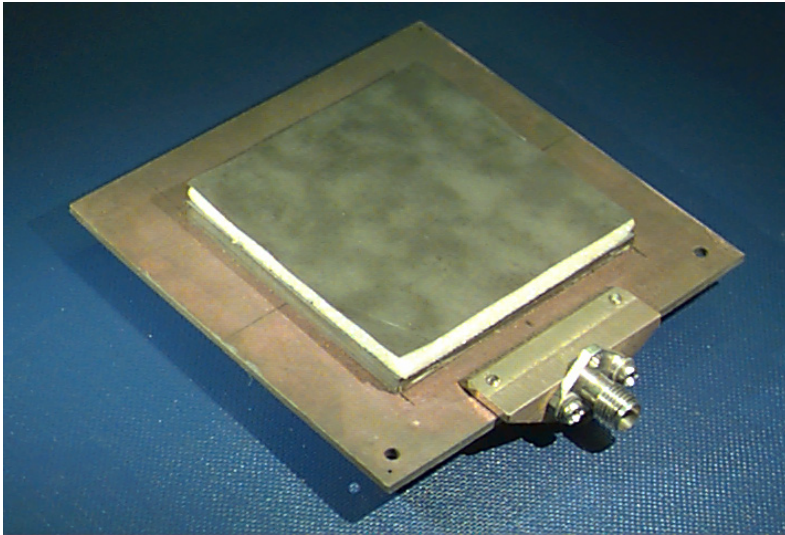


# ECE 6345

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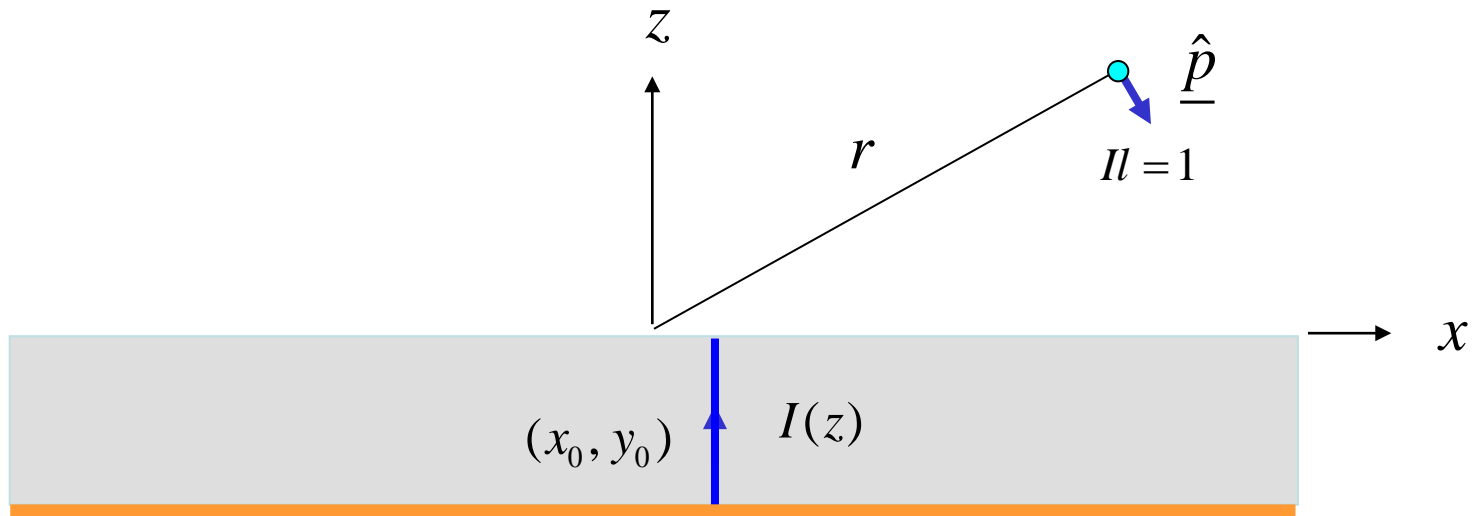
Notes 8

# Overview

In this set of notes we calculate the far field of a vertical probe feed.

- We first formulate the far-field radiation from a uniform probe current of fixed (arbitrary) amplitude.
- The probe current is then related to patch input impedance.

# Radiation from Probe Current



The origin is at the center of the patch (which has been removed).

$$E_{\phi}^{FF} = 0$$

This follows from reciprocity, since

$$\hat{\phi} \cdot \hat{z} = 0$$

$$E_{\theta}^{FF}(r, \theta, \varphi) = \langle b, a \rangle$$

$$= \int_{-h}^0 I(z) E_z^{pw}(z) dz$$

# Radiation from Probe Current (cont.)

Inside the substrate we have

$$\begin{aligned} E_z &= \frac{1}{j\omega\epsilon_1} (\nabla \times \underline{H}) \cdot \hat{z} \\ &= \frac{1}{j\omega\epsilon_1} \left( \frac{\partial H_y}{\partial x} - \frac{\partial H_x}{\partial y} \right) \end{aligned}$$

Transverse variation:

$$e^{j(k_x x + k_y y)}$$

Hence 
$$E_z^b = \frac{1}{j\omega\epsilon_1} \left[ jk_x H_y^{pw} - jk_y H_x^{pw} \right]$$

# Radiation from Probe Current (cont.)

$$\underline{H}^{ipw} = \underline{\hat{\phi}} \left( -\frac{E_{\theta}^{ipw}}{\eta_0} \right) = \underline{\hat{\phi}} \left( -\frac{E_0}{\eta_0} \right) e^{j(k_x x + k_y y + k_z z)}$$

$$H_x^{ipw} = -\frac{E_0}{\eta_0} e^{j(k_x x + k_y y + k_z z)} (-\sin \phi)$$

$$H_y^{ipw} = -\frac{E_0}{\eta_0} e^{j(k_x x + k_y y + k_z z)} \cos \phi$$

# Radiation from Probe Current (cont.)

For the total (incident plus reflected) plane-wave field we have  
(for the  $x$  component):

$$\begin{aligned} H_x^{pw}(x_0, y_0, 0) &= H_x^{ipw}(x_0, y_0, 0)(1 - \Gamma^{TM}) \\ &= \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} \sin \phi (1 - \Gamma^{TM}) \end{aligned}$$

Denote  $H_x^{pw}(x_0, y_0, z) = f(z)$

$$= A \cos(k_{z1}(z + h))$$

where

$$\begin{aligned} k_{z1} &= (k_1^2 - k_x^2 - k_y^2)^{1/2} \\ &= (k_1^2 - k_0^2 \sin^2 \theta)^{1/2} \\ &= k_0 \sqrt{\epsilon_r - \sin^2 \theta} \\ &= k_0 N_1(\theta) \end{aligned}$$

Setting  $z = 0$  we have  $A = \frac{H_x^{pw}(x_0, y_0, 0)}{\cos(k_{z1}h)}$

Hence  $H_x^{pw}(x_0, y_0, z) = H_x^{pw}(x_0, y_0, 0) \left[ \frac{\cos(k_{z1}(z + h))}{\cos(k_{z1}h)} \right]$

# Radiation from Probe Current (cont.)

We then have

$$H_x^{pw}(x_0, y_0, z) = \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \sin \phi \sec(k_{z1} h) \cos k_{z1} (z + h)$$

Similarly,

$$H_y^{pw}(x_0, y_0, z) = \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) (-\cos \phi) \sec(k_{z1} h) \cos k_{z1} (z + h)$$

Next, use

$$k_x = k_0 \sin \theta \cos \phi$$

$$k_y = k_0 \sin \theta \sin \phi$$

# Radiation from Probe Current (cont.)

Recall: 
$$E_z^{pw} = \frac{1}{\omega \epsilon_1} \left[ k_x H_y^{pw} - k_y H_x^{pw} \right]$$

so

$$E_z^{pw} = \frac{1}{\omega \epsilon_1} \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \sec(k_{z1} h) \cos k_{z1} (z + h) \cdot \left[ k_0 \sin \theta (-\cos^2 \phi - \sin^2 \phi) \right]$$

or

$$\begin{aligned} E_z^{pw} &= -\frac{1}{\omega \epsilon_1} \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \sec(k_{z1} h) \cos k_{z1} (z + h) k_0 \sin \theta \\ &= -\frac{1}{\epsilon_r} E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \sec(k_{z1} h) \cos k_{z1} (z + h) \sin \theta \end{aligned}$$



# Radiation from Probe Current (cont.)

The far field pattern is then

$$E_{\theta}^{FF}(r, \theta) = \frac{-1}{\epsilon_r} E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \sec(k_{z1} h) \sin \theta \int_{-h}^0 I(z) \cos(k_{z1}(z+h)) dz$$

Assume  $I(z) = I_0$

$$\begin{aligned} \int_{-h}^0 I(z) \cos(k_{z1}(z+h)) dz &= I_0 \int_{-h}^0 \cos(k_{z1}(z+h)) dz \\ &= I_0 \int_0^h \cos(k_{z1}u) du \\ &= \frac{I_0}{k_{z1}} \sin(k_{z1}h) \\ &= I_0 h \operatorname{sinc}(k_{z1}h) \end{aligned}$$

# Radiation from Probe Current (cont.)

Hence

$$E_{\theta}^{FF}(r, \theta) = \frac{-1}{\epsilon_r} E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \sec(k_{z1} h) [(I_0 h) \text{sinc}(k_{z1} h) \sin \theta]$$

or

$$E_{\theta}^{FF}(r, \theta) = (I_0 h) \left( \frac{-1}{\epsilon_r} \right) E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{TM}) \text{tanc}(k_0 h N_1(\theta)) \sin \theta$$

where

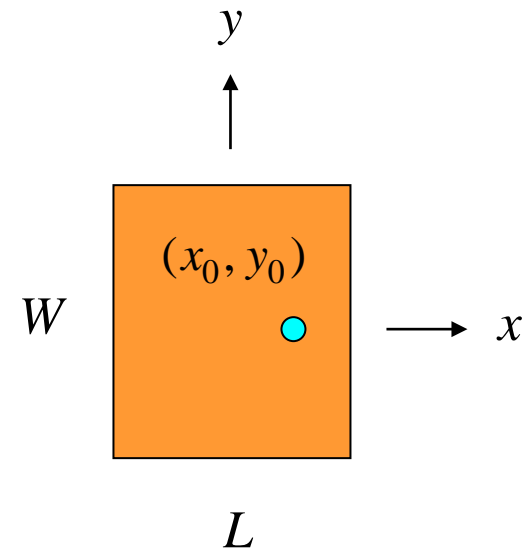
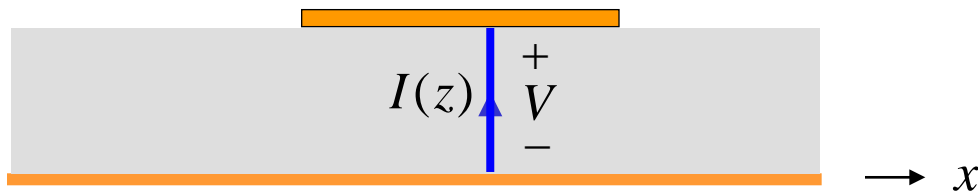
$$\text{tanc}(x) = \frac{\tan(x)}{x}$$

# Calculation of Probe Current

We want to find the relation between these two.

$$J_{sx}(x, y) = A_{10}^J \cos\left(\frac{\pi x}{L}\right)$$

$$I(z) = I_0$$



$$V = Z_{in} I_0 = -h E_z(x_0, y_0)$$

$Z_{in}$  = input impedance of dominant mode.

Hence

$$E_z(x_0, y_0) = -\frac{Z_{in} I_0}{h}$$

# Calculation of Probe Current (cont.)

Assume  $E_z^{10}(x, y) = A_{10}^E \sin\left(\frac{\pi x}{L}\right)$

Then 
$$A_{10}^E = \frac{E_z^{10}(x_0, y_0)}{\sin\left(\frac{\pi x_0}{L}\right)}$$
$$= \frac{-Z_{in} I_0}{h \sin\left(\frac{\pi x_0}{L}\right)}$$

Therefore,

$$E_z^{10}(x, y) = \left[ \frac{-Z_{in} I_0}{h \sin\left(\frac{\pi x_0}{L}\right)} \right] \sin\left(\frac{\pi x}{L}\right)$$

# Calculation of Probe Current (cont.)

From previous calculations,

$$\underline{J}_s = \frac{1}{j\omega\mu} \nabla E_z$$

Hence

$$J_{sx}^{10} = \frac{1}{j\omega\mu} \left( \frac{\pi}{L} \right) \left[ \frac{-Z_{in} I_0}{h \sin \left( \frac{\pi x_0}{L} \right)} \right] \cos \left( \frac{\pi x}{L} \right) = A_{10}^J \cos \left( \frac{\pi x}{L} \right)$$

so that

$$A_{10}^J = -\frac{1}{j\omega\mu} \left( \frac{\pi}{L} \right) \left[ \frac{Z_{in} I_0}{h \sin \left( \frac{\pi x_0}{L} \right)} \right]$$

or

$$\frac{A_{10}^J}{I_0} = -\frac{1}{j\omega\mu} \left( \frac{\pi}{L} \right) \left[ \frac{Z_{in}}{h \sin \left( \frac{\pi x_0}{L} \right)} \right]$$

# Calculation of Probe Current (cont.)

At resonance,

$$Z_{in} = R_{edge} \sin^2 \left( \frac{\pi x_0}{L} \right) \quad \text{(The origin is at the center of the patch.)}$$

Hence,

$$\frac{A_{10}^J}{I_0} = -\frac{1}{j\omega\mu} \left( \frac{\pi}{L} \right) \left[ \frac{R_{edge}}{h} \right] \sin \left( \frac{\pi x_0}{L} \right)$$

# Calculation of Probe Current (cont.)

We can also write this as

$$\begin{aligned}\frac{I_{patch}}{I_0} &= \frac{WA_{10}^J}{I_0} = -\frac{\pi}{j\omega\mu} \left(\frac{W}{L}\right) \left[\frac{R_{edge}}{h}\right] \sin\left(\frac{\pi x_0}{L}\right) \\ &= j \frac{\pi}{k_0\eta_0} \left(\frac{W}{L}\right) \left[\frac{R_{edge}}{h}\right] \sin\left(\frac{\pi x_0}{L}\right)\end{aligned}$$

$I_{patch}$  is the total current flowing across the center of the patch.

so

$$\frac{I_{patch}}{I_0} = j \frac{\pi}{\eta_0} \left(\frac{1}{k_0 h}\right) \left(\frac{W}{L}\right) R_{edge} \sin\left(\frac{\pi x_0}{L}\right)$$

# Calculation of Probe Current (cont.)

Hence,

$$\frac{I_{patch}}{I_0} = j\pi \frac{R_{edge}}{\eta_0} \left( \frac{1}{k_0 h} \right) \left( \frac{W}{L} \right) \sin \left( \frac{\pi x_0}{L} \right)$$

Note: For a thin substrate, the patch current is much larger than the probe current.

Note:  $I_0 h \propto (k_0 h)^2$  (This is a measure of how strong the probe radiates.)

The probe radiation gets small quickly as the substrate gets thinner.